

**Search Notes**

Application/Control No.

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Examiner

Jungwon Chang

Applicant(s)/Patent under  
Reexamination

BASANI ET AL.

Art Unit

2154

**SEARCHED**

Class	Subclass	Date	Examiner
709	229	7/18/2005	JWC
709	244	7/18/2005	JWC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
709	229	7/18/2005	JWC
709	244	7/18/2005	JWC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search NPL: Google ACM IEEE search report attached	7/18/2005	JWC